

<b>Notice of References Cited</b>	Application/Control No. 10/627,725	Applicant(s)/Patent Under Reexamination KWEON ET AL.	
	Examiner Jonathan S. Crepeau	Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,383,235	05-2002	Maegawa et al.	29/623.5
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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